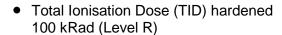
BUY15CS23J-01

HiRel RadHard Power-MOS

- Low R_{DS(on)}
- Single Event Effect (SEE) hardened

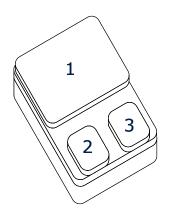
LET 73, Range: 253 μ m (Xe) LET 55, Range: 95 μ m (Xe) V_{GS} = -10V, V_{DS} = 150V V_{GS} = -15V, V_{DS} = 150V V_{GS} = -20V, V_{DS} = 100V



- Hermetically sealed
- N-channel
- **@esa** Space Qualified

ESA/SCC Detail Spec. No.: 5205/031

Type Variant No. 01



Туре	Marking	Pin Configuration			Package	
		1	2	3	-	
BUY15CS23J-01	-	D	G	S	-	SMD05

Maximum Ratings

Parameter	Symbol	Values	Unit
Drain Source Voltage	V _{DS}	150	V
Gate Source Voltage	V _{GS}	+/- 20	V
Drain Gate Voltage	V_{DG}	150	V
Continuous Drain Current $T_C = 25 ^{\circ}\text{C}$ $T_C = 100 ^{\circ}\text{C}$	I _D	23 15	A
Continuous Source Current	Is	23	А
Drain Current Pulsed, t _p limited by T _{jmax}	I _{DM}	93	Apk
Total Power Dissipation 1)	P _{tot}	75	W
Operating and Storage Temperature	T _{op}	-55 to + 150	°C
Avalanche Energy	E _{AS}	90	mJ

Thermal Characteristics

Thermal Resistance (Junction to Case)	R _{th JC}	1.66	K/W
Soldering Temperature	T _{sol}	250	°C

Notes:

1) For $T_S \le 25^{\circ}$ C. For $T_S > 25^{\circ}$ C derating is required.

IFAG PMM RFS D HIR 1 of 8 V5, May 2016



BUY15CS23J-01

Electrical Characteristics,	at T _A =25°C; unless o	therwise specified
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Parameter	Symbol Valu		Value	S	Unit
		min.	typ.	max.	
DC Characteristics					
Breakdown Voltage Drain to Source $I_D = 0.25$ mA, $V_{GS} = 0$ V	B _{VDSS}	150	-	-	V
Temperature Coefficient of B _{VDSS}	$\Delta BV_{DSS}/\Delta T_{J}$	-	0.20	-	V/°C
Gate Threshold Voltage $I_D = 1.0 \text{mA}, V_{DS} \ge V_{GS}$	V _{GS(th)}	2.0	-	4.0	V
Gate to Source Leakage Current $V_{DS} = 0V$, $V_{GS} = +/-20V$	I _{GSS}	-	-	+/-100	nA
Drain Current $V_{DS} = 120V$, $V_{GS} = 0V$	I _{DSS}	-	-	25	μΑ
Drain Source On Resistance $^{1)}$ $V_{GS} = 10V$, $I_D = 15A$	R _{DS(ON)}	-	51	60	mΩ
Source Drain Diode, Forward Voltage $^{1), 2)}$ $V_{GS} = 0V$, $I_S = 23A$	V _{SD}	-	-	1.2	V
AC Characteristics	1	L			1
Turn-on Delay Time $V_{DD} = 50\% \ V_{DS}, \ I_D = 15A, \ R_G = 4.7\Omega$	t _{d(ON)}	-	-	30	ns
Rise Time V_{DD} = 50% V_{DS} , I_D = 15A, R_G = 4.7 Ω	t _r	-	-	50	ns
Turn-off Delay Time $V_{DD} = 50\% V_{DS}$, $I_D = 15A$, $R_G = 4.7\Omega$	t _{d(OFF)}	-	-	40	ns
Fall Time V_{DD} = 50% V_{DS} , I_D = 15A, R_G = 4.7 Ω	t _f	-	-	40	ns
Reverse Recovery Time $V_{DD} < 50\% V_{DS}$, $I_D = 23A$	t _{rr}	-	-	300	ns
Common Source Input Capacitance V _{DS} = 100V, V _{GS} = 0V, f = 1.0MHz	C _{iss}	1000	1500	1700	pF
Common Source Output Capacitance $V_{DS} = 100V$, $V_{GS} = 0V$, $f = 1.0MHz$	C _{oss}	140	160	200	pF
Common Source Reverse Transfer Capacitance $V_{DS} = 100V$, $V_{GS} = 0V$, $f = 1.0MHz$	C _{rss}	5	23	30	pF
Gate Resistance	R _G	-	1.4	-	Ω
Total Gate Charge $V_{DD} = 50\% V_{DS}$, $V_{GS} = 10V$, $I_D = 23A$	Q _G	-	-	32	nC

IFAG PMM RFS D HIR 2 of 8 V5, May 2016

Notes:
1) Pulsed Measurement: Pulse Width < 300µs, Duty Cycle <2.0%.
2) Measured within 2.0 mm of case.



BUY15CS23J-01

Electrical Characteristics

at T_A=125°C; unless otherwise specified

Parameter	Symbol	Values		Unit	
		min.	max.		
DC Characteristics					
Gate Threshold Voltage $I_D = 1.0 \text{mA}, V_{DS} \ge V_{GS}$	$V_{GS(th)}$	1.5	-	V	
Gate to Source Leakage Current $V_{DS} = 0V$, $V_{GS} = +/-20V$	I _{GSS}	-	+/-200	nA	
Drain Current $V_{DS} = 120V$, $V_{GS} = 0V$	I _{DSS}	-	250	μΑ	
Drain Source On Resistance ¹⁾ V _{GS} = 10V, I _D = 15A	r _{DS(ON)}	-	110	mΩ	

Electrical Characteristics

at T_A=-55°C; unless otherwise specified

Parameter	Symbol	Values		Unit
		min.	max.	
DC Characteristics				
Gate Threshold Voltage $I_D = 1.0 \text{mA}, V_{DS} \ge V_{GS}$	$V_{GS(th)}$	-	5.0	V

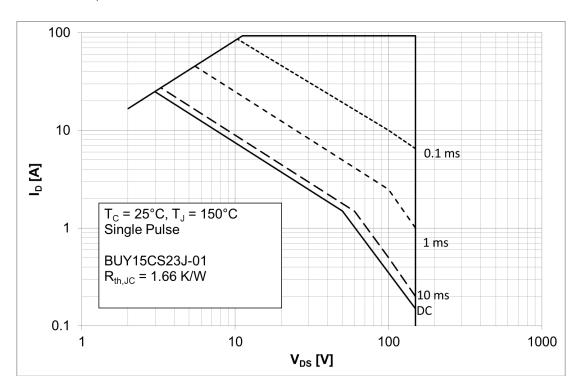
Notes:
1) Pulsed Measurement: Pulse Width < 300µs, Duty Cycle <2.0%.



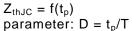
1 Safe operating area

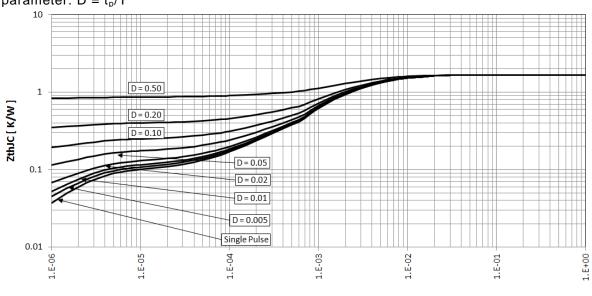
 $I_D = f(V_{DS}); T_C = 25^{\circ}C$

parameter: t_p



2 Max. transient thermal impedance

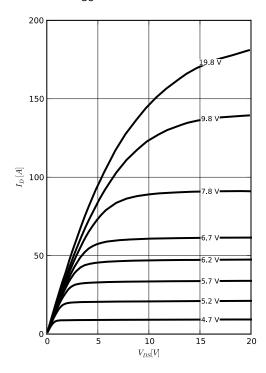




t_pulse_rec [sec]

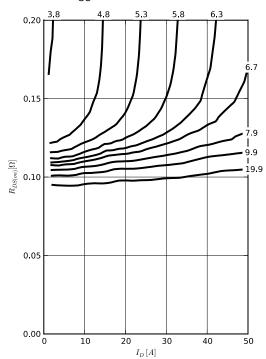
3 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25 \text{ °C}$ parameter: V_{GS}



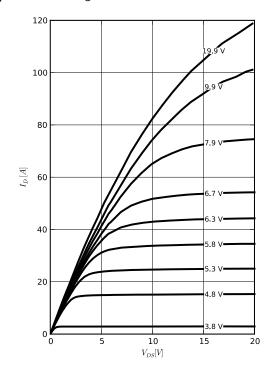
5 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(I_D); T_j = 150 \text{ °C}$ parameter: V_{GS}



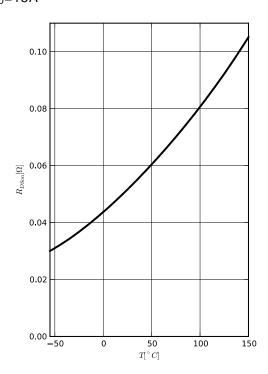
4 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 150 \text{ °C}$ parameter: V_G



6 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(T_j)$ $I_D=15A$

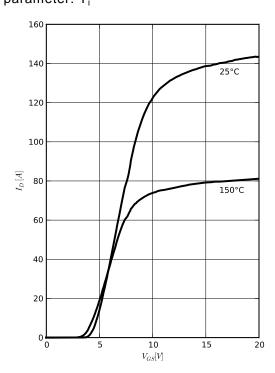




BUY15CS23J-01

7 Typ. transfer characteristics

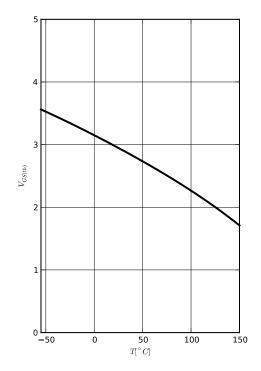
$$I_D = f(V_{GS}); VDS = 10V$$
 parameter: T_i



8 Typ. gate threshold voltage

$$I_D = f(T_j)$$

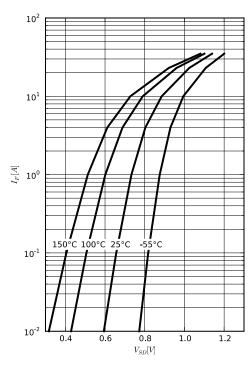
 $I_D = 1 \text{mA}$



9 Typ. forward characteristics of reverse diode

$$I_F = f(V_{SD})$$

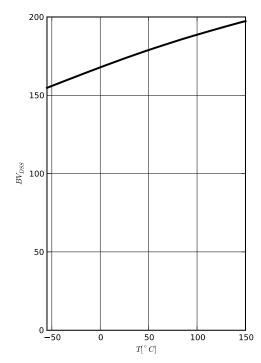
parameter: T_i



10 Typ. drain-source breakdown voltage

$$BV_{DSS} = f(T_j)$$

 $I_D = 250\mu A$

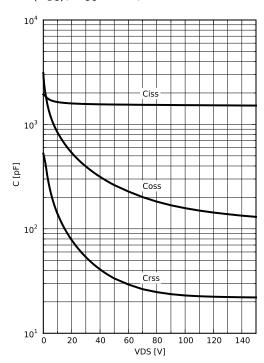




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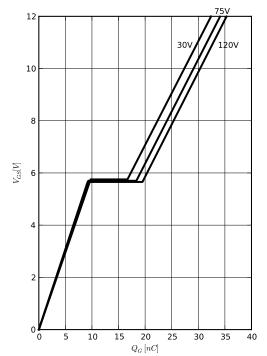
11 Typ. capacitances

$$C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$$



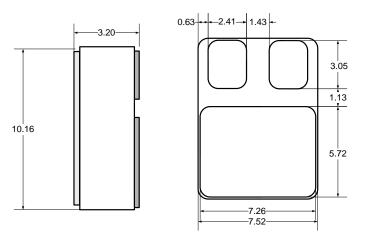
12 Typ. gate charge

$$V_{GS} = f(Q_{gate}); ID = 23 A pulsed parameter: V_{DD}$$



BUY15CS23J-01

SMD05 Package



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Dimensions are typical [mm]

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